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Dieter LEHMANN et al.I.A. Filing Date  
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Unknown

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
N.M.B./		5 5 7 6 1 0 6	11/19/96	KERBOW et al.			
		4 8 3 5 1 3 0	05/24/83	MOLINSKI et al.			
		3 2 9 8 9 4 2	<del>05/20/58</del>	MAGAT et al.		01/19/04	
		6 3 8 7 9 6 4	05/14/02	D'AGOSTINO et al.			
		6 2 2 5 3 6 8	05/01/01	D'AGOSTINO et al.			
		5 7 5 6 1 9 9	05/26/98	KERBOW et al.			
		6 7 7 0 3 7 8	08/03/04	LEHMANN			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
N.M.B./		1 5 1 6 6 4 8	07/05/78	GREAT BRITAIN			
	9	6 / 0 3 4 4 8	02/08/96	W.I.P.O.			
		1 4 6 7 1 6	10/22/79	GERMANY			
		2 3 1 8 8 9 6	02/18/77	FRANCE			
	2004	- 1 0 7 4 6 1	04/08/04	JAPAN			
	1	9 8 2 3 6 0 9	12/02/99	GERMANY			
	9	9 / 6 1 5 2 7	12/02/99	W.I.P.O.			
	63	- 0 0 7 4 5 5	01/13/88	JAPAN			
		2 4 9 4 7 0 2	05/28/82	FRANCE			

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

N.M.B./	1	A. Heger et al., Technologie der Strahlenchemie an Polymeren, Akademie-Verlag Berlin 1990, 463-488 and 496-501.
	2	Ferse et al., Plaste u. Kautschuk, 29 (1982), 45-465.
	3	K. Schierholz et al., J. Polym. Sci. Part B, Polymer Physics, Vol. 37, 2404-2411 (1999).
	4	English Language Abstract of FR 2318896. date unknown
	5	English Language Abstract of JP 2004-107461. date unknown
	6	Dargaville et al., "High Energy Radiation Grafting Of Fluoropolymers", Prog. Poly. Sci. 28 (2003) 1355-1376.
	7	English Language Abstract of JP 63-007455. date unknown
	8	Patent Abstracts of Japan, Vol. 011, No. 222 (C-435), July 18, 1987
	9	Patent Abstracts of Japan, Vol. 2003, No. 03, May 5, 2003
	10	Patent Abstracts of Japan, Vol. 014, No. 252 (E-0934), May 20, 1990

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.